

Notice of References Cited	Application/Control No. 10/002,915	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner BRIAN P. YENKE	Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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X	B	US-6,829,013	12-2004	Thompson et al.	348/448
X	C	US-6,795,123	09-2004	Gotanda et al.	348/448
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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